Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination SHAUGHNESSY, STEVEN T. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|-----|--|-----------------|----------------|----------------|
| * | Α | US-5,701,480 A | 12-1997 | Raz, Yoav | 718/101 |
| * | В | US-5,715,447 A | 02-1998 | Hayashi et al. | 707/8 |
| * | С | US-6,618,822 B1 | 09-2003 | Loaiza et al. | 714/20 |
| * | D | US-6,990,503 B1 | 01-2006 | Luo et al. | 707/200 |
| | Е | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | Н | US- | | | |
| | - 1 | US- | | | |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | · | | |
| • | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
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| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | • | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| | NOTE A POSSIBLE TO | | | | | | |
|---|--------------------|---|--|--|--|--|--|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | | | |
| * | U | The Authoritative Dictionary of IEEE Standards Terms, Seventh Edition, IEEE Press, 2000 | | | | | |
| | V | | | | | | |
| | w., | | | | | | |
| | х | | | | | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.